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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In re Application of ) BOX PCT 10/018460  
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Erlend RØNNEKLEIV ) PCT/NO00/00219  
)  
) International Filing Date:  
Filed: December 19, 2001 ) June 22, 2000  
)  
For: ELIMINATION OF POLARIZATION  
FADING IN UNBALANCED OPTICAL  
MEASURING INTERFEROMETERS

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents  
Washington, D.C. 20231

Dear Sir:

Under the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98,  
Applicant submits herewith copies of the following publications  
that the Office may wish to consider in examination of the  
subject application. The publications are also listed on the  
attached form PTO-1449 and were included in the enclosed  
International Search Report for PCT/NO00/00219. Applicant also  
submits the Norwegian Search Report for PCT/NO00/00219.

Respectfully submitted,

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Enclosures: 5

2036-200.Ids

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>				<i>Complete if Known</i>	
				Application Number	PCT/NO00/00219
				Filing Date	June 22, 2000
				First Named Inventor	Erlend RØNNEKLEIV
				Group Art Unit	
				Examiner Name	
Sheet	1	of	1	Attorney Docket Number	2036-200

### U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code <sup>2</sup> (if known)		
	1	4,897,543		KERSEY	Jan. 30, 1990
	2	5,173,743		KIM	Dec. 22, 1992
	3	5,351,124		LASKOSKIE, et al.	Sep. 27, 1994

### FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee of Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	T <sup>6</sup>
		Office <sup>3</sup> Code	Number <sup>4</sup>	Kind <sup>5</sup> (if known)			

Examiner Signature		Date Considered	
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code. <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.